

PRODUCT SPECIFICATION

PRODUCT NAMEMINIDISPLAYPORTPRODUCT NO :MiniDisplay portFemale seriesSpec

DATE : <u>2013-05-18</u> **REVISION** : <u>A</u>

Rev.	Revised	Originator	Issue Date
1	NEW	STEVEN	2013.05.18





1. SCOPE

1.1 Content

This specification is designated the Performance, Tests and quality requirements for Display port Connector.

1.2 Design and Construction

Product shall be conformed the Design, Construction and Physical dimensions shown as product drawing.

2. Material

Connector

Contact	:	Brass, contact area G/F, solder area MATTE TIN, nickel underplate.
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Housing : High temperature thermoplastic, UL94V-0 black.

Shell : Sstainless Steel, nickel plating.

3. Specification

Current Rating	:	0.5A per contact minimum
Voltage Rating	:	40V AC(RMS)
Operating temperature	:	-25°C \sim +85°C





4. Test description

NO	TEST ITEM	TEST CONDITION	REQUIREMENT		
1	Vibration	Amplitude : 1.52mm P-P or 147m/s2 {15G} Sweep time: 50-2000-50Hz in 20 minutes. Duration : 12 times in each (total of 36 Times) X, Y, Z axes. Electrical load : DC100mA current shall be Flowed during the test.	Appearance Contact Resistance	No Damage Contact : Change from initial value: 30 milliohms maximum. Shell Part : Change from initial value: 50 milliohms maximum.	
		(ANSI/EIA-364-28 Condition III)	Discontinuity	1 μsec maximum.	
2	Shock	Pulse width: 11 msec., Waveform : half sine, 490m/s2{50G}, 3 strokes in each X.Y.Z. axes (ANSI/EIA-364-27, Condition A)	Appearance Contact Resistance Discontinuity	No Damage Contact : Change from initial value: 30 milliohms maximum. Shell : Change from initial value: 50 milliohms maximum. 1 µsec maximum.	
3	Durability	Measure contact and shell resistance after Following. Automatic cycling : 10,000 cycles at 100 \pm 50 cycles per hour	Contact Resistance	Contact : Change from initial value: 30 milliohms maximum. Shell : Change from initial value: 50 milliohms maximum.	
4	Insertion / Withdrawal Force	Insertion and withdrawal speed : 25mm/minute. (ANSI/EIA-364-13)	Insertion force Withdrawal force	4.5 kgf maximum 1.0~4.0 kgf	





NO	TEST ITEM	TEST CONDITION	REQUIREMENT
5	Contact Resistance	Mated connectors, Contact : measure by dry circuit, 20 mVolts maximum.,10mA. Shell : measured by open circuit, 5 Volts maximum ,100mA. (ANSI/EIA-364-06B)	Initial Contact resistance excluding conductor resistance: 10 milliohms maximum . (Target design value)
6	Dielectric Strength	Unmated connectors, apply: 500Volts AC(RMS.) between adjacent terminal or ground. Mated: mated connector, apply 300Volts AC(RMS.) between adjacent terminal or ground. (ANSI/EIA-364-20C, Method A)	No Breakdown
7	Insulation Resistance	Unmated connectors, apply 500 Volts DC between adjacent terminal or ground. (ANSI/EIA 364-21C)	100 megaohms minimum (unmated)
		Mated connectors, apply 150 Volts DC between adjacent terminal or ground.	10 megaohms minimum (mated)
8	Contact Current Rating	55 ℃, maximum ambient 85 ℃, maximum temperature change (ANSI/EIA-364-70A)	0.5 A minimum
9	Applied Voltage Rating	40 Volts AC (RMS.) continuous maximum, on any signal pin with respect to the shield.	No Breakdown





NO	TEST ITEM	TEST CONDITION	REQUIREMENT		
10	TMDS Signals Time Domain Impedance	Rise time ≤ 200 psec (10%-90%). Signal to Ground pin ratio per HDMI designation. Differential Measurement Specimen Environment Impedance = 100 ohms differential Source-side receptacle connector mounted on a controlled impedance PCB fixture. (ANSI/EIA-364-108)	Connector Area : 100 ol	nms ±15%	
11	TMDS Signals Time Domain Cross talk FEXT	Rise time ≤ 200 psec (10%-90%). Signal to Ground pin ratio per HDMI designation. Differential Measurement Specimen Environment Impedance = 100 ohms differential. Source-side receptacle connector mounted on controlled impedance PCB fixture. Driven pair and victim pair. (ANSI/EIA-364-90)	5% maximum		
12	Thermal Shock	10 cycles of : a) -55 ℃ for 30 minutes b) +85 ℃ for 30 minutes (ANSI/EIA-364-32C, Condition I)	Resistance initial val 30 milliol maximum Shell Part Change fr	Change from ue: nms n. : : rom initial 60 milliohms	





NO	TEST ITEM	TEST CONDITION		RE	QUIREMENT
13	Humidity		Atte connectors together d perform the test as lows. Inperature : +25 to +85 °C lative Humidity : 80 to % Duration : 4 cycles (96 ars) Upon completion of test, specimens shall be nditioned at ambient room nditions for 24 hours, er which the specified assurements shall be formed. NSI/EIA-364-31B) mated each connectors	Appearance Contact Resistance Appearance	No Damage Contact : Change from initial value: 30 milliohms maximum. Shell : Change from initial value: 50 milliohms maximum.
		B fol Te: Re 95% how the con afte me per	I perform the test as lows. mperature : $+25$ to $+85$ °C lative Humidity : 80 to % Duration : 4 cycles (96 urs) Upon completion of test, specimens shall be nditioned at ambient room nditions for 24 hours, er which the specified assurements shall be formed. NSI/EIA-364-31B)	Dielectric Withstandin g Voltage and Insulation Resistance	Conform to item of Dielectric Withstanding Voltage and Insulation Resistance
NO	TEST ITEM	Т	EST CONDITION	RE	QUIREMENT
14	Thermal Aging	Mate connectors and expose to +105 ± 2 °C for 250 hours. Upon completion of the exposure period, the test specimens shall be conditioned at ambient room conditions for 1 to 2 hours, after which the specified measurements shall be performed. (ANSI/EIA-364-17B, Condition 4, Method A)		AppearanceNo DamageContactContact :ResistanceChange from initial value: 30 milliohm maximum.Shell Part :Change from initial value: 50 milliohm maximum.	





5. Test sequences:

Table I: Product Qualification Test Sequence									
Test Description	Test Group								
Test Description	А	В	С	D	Е	F	G	Н	J
Electrical Test:		1	1		1	1	1		
1. appearance	1, 8	1, 9	1, 9	1, 9	1, 9	1,11	1, 9	1, 9	1, 9
2. Contact Resistance	2, 5	2, 6	2, 6	2, 6	2, 6	2, 8	2, 6	2, 6	2, 6
3. Dielectric Strength	3, 6	3, 7	3, 7	3, 7	3, 7	3, 9	3, 7	3, 7	3, 7
4. Insulation Resistance	4, 7	4, 8	4, 8	4, 8	4, 8	4,10	4, 8	4, 8	4, 8
5. Contact Current Rating									
6. Applied Voltage Rating									
7. TMDS Signals Time Domain Impedance		5							
8. TMDS Signals Time Domain Cross talk FEXT			5						
Mechanical Test:									
9. Vibration				5					
10. Shock					5				
11. Durability						6			
12. Insertion/Withdrawal Force						5, 7			
Environmental Test:									
13. Thermal Shock							5		
14. Humidity								5	
15. Thermal Aging									5
Sample Quantity	6	6	6	6	6	6	6	6	6
Sample No.	A1 ↓ A5	B1 ↓ B5	C1 ↓ C5	D1 ↓ D5	E1 ↓ E5	F1 ↓ F5	G1 ↓ G5	H1 ↓ H5	J1 ↓ J5

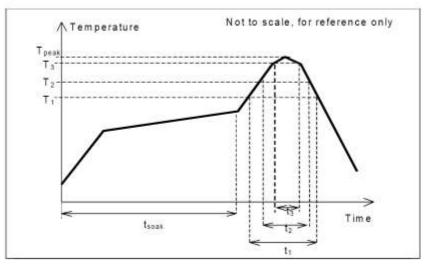




REFLOW SOLDERING PROFILE

Pb-free reflow profile requirements:

Parameter	Reference	Specification
Average temperature gradient in preheating		2.5 ℃/s
Soak time	tsoak	2-3 minutes
Time above 217 $^{\circ}$ C	t1	60 s
Time above 230 $^{\circ}$ C	t2	50 s
Time above 250 °C	t3	5 s
Peak temperature in reflow	Tpeak	255 ℃ (-0/+5 ℃)
Temperature gradient in cooling		Max -5 °C/s



This profile is the minimum requirement for evaluating soldering heat resistance of components. Heat transfer method used for reflow soldering is hot air convection. The actual air temperatures used to achieve the specified profile is higher and largely dependent on the reflow equipment.

